TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIII.5)

2SK1544

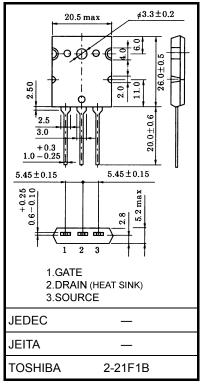
DC-DC Converter and Motor Drive Applications

Unit: mm

 $\begin{array}{ll} \bullet & \text{Low drain-source ON resistance} & : \text{RDS (ON)} = 0.15 \ \Omega \ \text{(typ.)} \\ \bullet & \text{High forward transfer admittance} & : |Y_{fs}| = 21 \ \text{S (typ.)} \\ \bullet & \text{Low leakage current} & : \text{IDSS} = 300 \ \mu\text{A (max)} \ \text{(VDS} = 500 \ \text{V)} \\ \bullet & \text{Enhancement mode} & : \text{Vth} = 1.5 \text{\sim} 3.5 \ \text{V (Vps} = 10 \ \text{V, Ip} = 1 \ \text{mA)} \\ \end{array}$

Absolute Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	500	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	500	V	
Gate-source voltage		V_{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	25	Α	
	Pulse (Note 1)	I _{DP}	100	A	
Drain power dissipation (Tc = 25°C)		P_{D}	200	W	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 9.75 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	0.625	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	35.7	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

This transistor is an electrostatic-sensitive device.

Please handle with caution.



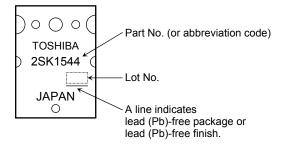
Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±25 V, V _{DS} = 0 V	_	_	±100	nA
Drain cut-off cur	rrent	I _{DSS}	V _{DS} = 500 V, V _{GS} = 0 V	_	_	300	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	500	_	_	V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source Ol	N resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 13 A	_	0.15	0.20	Ω
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 13 A	10	21	_	S
Input capacitano	:e	C _{iss}			3700	_	
Reverse transfer	r capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	400	_	pF
Output capacitance		Coss]		920	_	
Switching time	Rise time	t _r	$V_{GS} \stackrel{10V}{\text{OV}} \stackrel{I_{D}=13A}{\text{V}_{OUT}} \stackrel{V_{OUT}}{\text{RL}} = 16\Omega$	_	185	_	- ns
	Turn-on time	t _{on}		_	240	_	
	Fall time	t _f		_	250	_	
	Turn-off time	t _{off}	$V_{DD} = 200V$ Duty $\leq 1\%$, $t_W = 10 \mu s$	_	590	_	
Total gate charge (Gate-source plus gate-drain)		Qg			150		_
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 25 \text{ A}$		70	_	nC
Gate-drain ("miller") charge		Q _{gd}			80	_	

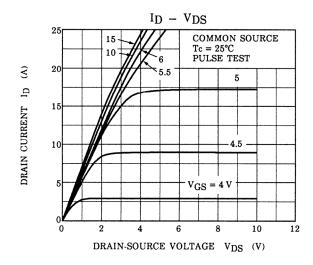
Source-Drain Ratings and Characteristics (Ta = 25°C)

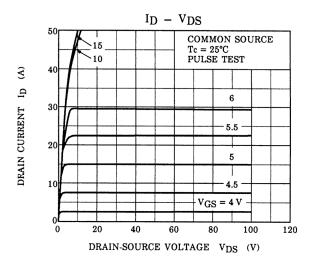
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	25	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	-	_	100	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 25 A, V _{GS} = 0 V	_	_	-1.6	V
Reverse recovery time	t _{rr}	I _{DR} = 25 A, V _{GS} = 0 V		780		ns
Reverse recovered charge	Q _{rr}	dI _{DR} / dt = 100 A / μs	_	9.8	_	μC

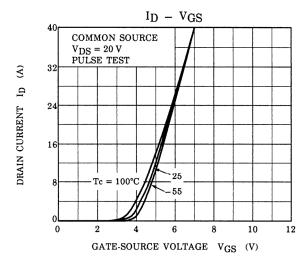
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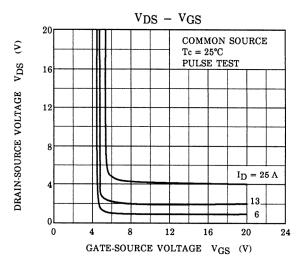


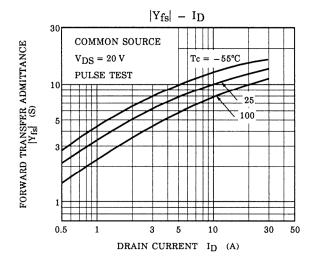
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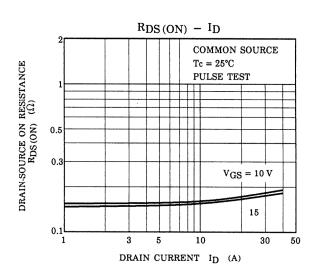


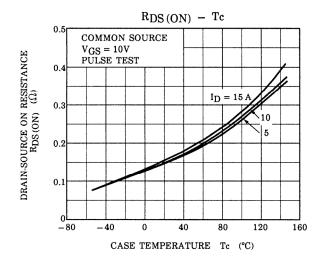


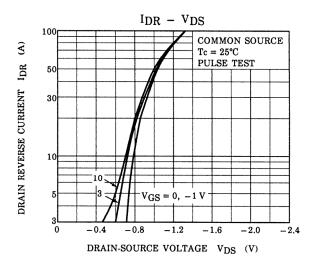


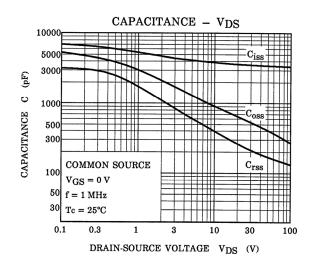


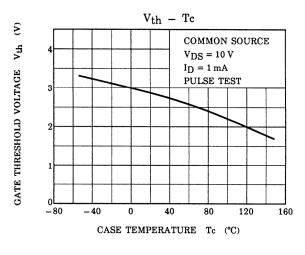


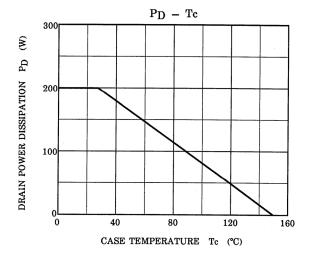


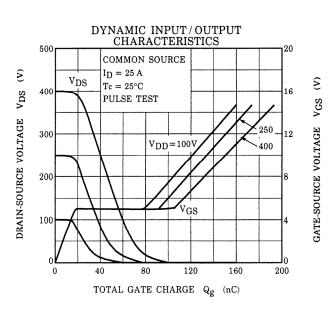


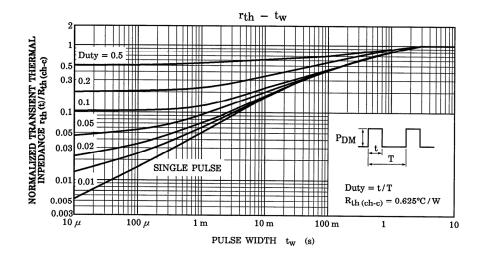


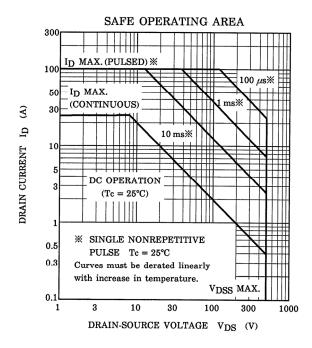












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